1 Dear Professor Jason Surratt,

2 We welcome the opportunity to revise and clarify our manuscript for publication in 3 *Atmospheric Chemistry and Physics*. Below is a point-by-point response to the comments of 4 reviewers.

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Anonymous referee #2

Although the revision has been improved, I am not still fully convinced that the results can be 6 applied to the environmentally relevant conditions. Charan et al. (2022) claimed that the yield 7 8 of SOA depended strongly on OH concentration rather than OH exposure. Since the authors 9 used a fixed residence time of 2 min in the OFR, the exposure reported was a directly proportional to OH concentration, which should be the governing factor for SOA formation. 10 The OH exposure (OH concentration multiplied by exposure duration) and photochemical age 11 can be used interchangeably using an assumption of a constant OH concentration. Under an 12 13 ideal condition, a low OH concentration for a long exposure time and a high OH concentration for a short exposure time can achieve the same degree of degradation of the parent compound. 14 However, that is not for the formation of SOA as Charan et al. (2022) asserted. Since OH 15 16 concentrations in the OFR were >1,000 times greater than the average OH concentration in air, the result of SOA formation yield should not be applied to the prediction in the real atmosphere. 17 The predicted SOA concentrations were overestimated when compared with other predictions 18 in the literature. Thus, the current section of 4 Conclusions and implications should be properly 19 20 revised.

Re: We agree that the SOA yield depends on the OH concentration. Charan et al. also claimed 21 that the SOA yield varied in a small range (0-6%) at the OH concentration $< 5 \times 10^8$ molecules 22 cm⁻³ (Atmos. Chem. Phys., 2022, 22, 917-928). It was assumed that the SOA yields at 23 environmentally relevant OH concentrations ($\sim 10^6$ molecules cm⁻³) were similar to those at the 24 lowest OH concentrations (~ 10^8 molecules cm⁻³) used here. Thus, the high-NO_x SOA yields 25 (D3: 0.038; D4: 0.001; D5: 0.011; D6: 0.000) under the seeded conditions at the OH 26 concentration of 6.83×10^8 molecules cm⁻³ (0.63 equivalent days) were employed in the 27 calculation of cVMS SOA concentrations at urban sites, while the low-NO_x SOA yields (D3: 28

29 0.041; D4: 0.013; D5: 0.023; D6: 0.004) under the unseeded conditions at the OH concentration 30 of 4.57×10^8 molecules cm⁻³ (0.42 equivalent days) were used to estimate cVMS SOA at 31 background and polar sites.

It was noted that the time-integrated consumption over the lifetime of a precursor compound 32 in the atmosphere should be suitable for evaluating the SOA formation. As you stated, under 33 an ideal condition, a low OH concentration for a long exposure time and a high OH 34 concentration for a short exposure time can achieve the same degree of degradation of the 35 precursor compound. Accordingly, when considering half-lives (6-30 days) of cVMS in the 36 atmosphere, the $\Delta C_{cVMS}/C_{in-cVMS}$ values in low-NO_x and unseeded experiments at 14.2 37 equivalent days (Table S7) are used to calculate cVMS SOA at background and polar sites. Due 38 to a short residence time of airmass over urban areas, the $\Delta C_{cVMS}/C_{in-cVMS}$ values in high-NO_x 39 and seeded experiments at 0.63 equivalent days (Table S7) are employed to estimate cVMS 40 SOA at urban sites. 41

The related descriptions have been given in Lines 371-377, 379-382 and 384-392 in the revised manuscript. The section of conclusions and implications has been properly modified on the basis of the updated data in Figure 4 in the revised manuscript, and in Tables S6-7 in the revised *Supplement*.

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Anonymous referee #3

48 Main Points

1) I thank the authors for their additional text regarding the back of the envelope calculations 49 on cVMS SOA concentrations. I think these types of calculations are valuable. However, I am 50 still unconvinced by the arguments regarding the choice of 8.5 days. I agree that the SOA 51 formation will occur as the airmass is transported and that for this type of calculation 52 simplification is required. I disagree though that 8.5 days is the appropriate choice. As the 53 airmass is transported it will undergo dilution in addition to chemical processing. For the 54 equations used here, the aerosol is being calculated in terms of ng/m^3 and the dilution would 55 not be taken into account when using 8.5 days and measured gas-phase concentrations near the 56

source region. I think a more appropriate choice, particularly for the urban environment, would
be to select a yield associated with the photochemical age appropriate for an urban airmass (~1
day or less). The impact of dilution on the results should be discussed.

Re: There is a short residence time of airmass over urban areas. The cVMS SOA yields (D3: 60 0.038; D4: 0.001; D5: 0.011; D6: 0.000) and the $\Delta C_{cVMS}/C_{in-cVMS}$ values in high-NO_x and 61 seeded experiments at 0.63 equivalent days have been employed in the calculation of cVMS 62 SOA concentrations at urban sites. The dilution of cVMS would occur during the transportation 63 in the atmosphere, leading to an uncertainty of cVMS concentrations (C_{cVMS}) in the Equation 64 4. To simplify the estimation process, the effect of dilution on C_{eVMS} would not be taken into 65 account, and the reported C_{cVMS} values were directly used. The related descriptions have been 66 given in Lines 368-371, 375-377 and 387-389 in the revised manuscript. The section of 67 conclusions and implications has been properly modified on the basis of the updated data in 68 Figure 4 in the revised manuscript, and in Tables S6-7 in the revised Supplement. 69

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2) Si/O and Si/C ratio calculation. I thank the authors for the additional text clarifying the 71 72 calculation of the Si/O and Si/C ratios. However, I think the text requires a bit more elaboration to make the procedure clearer. From the way the calculation is written, it appears that the 73 number of Si or O in each ion is being used rather than the mass of Si and O. I think it is also 74 more appropriate to calculate the mass of Si and the mass of O separately then calculate the 75 Si/O making the appropriate adjustments for atomic ratios (Aiken et al., 2007). It is also unclear 76 to me why in equation S1 max is used in the denominator rather than sum if the fraction is 77 being calculated. Additionally, uncertainty in this calculation goes beyond simply uncertainty 78 79 in assigned peaks, but also includes fragmentation (see Aiken et al paper referenced above). 80 Re: The calculation methods of Si/O and Si/C ratios have been modified as follows: 81 (1) The peak intensity of $C_xH_yO_zSi_n$ ($C_{x1}H_{y1}O_{z1}Si_{n1}$, $C_{x2}H_{y2}O_{z2}Si_{n2}$... $C_{xi}H_{yi}O_{zi}Si_{ni}$) is obtained

- from the HR-ToF-AMS, which is named as $A_1, A_2...A_i$, respectively.
- 83 (2) The fraction of each $C_xH_yO_zSi_n$ ion $(F_1, F_2, F_3...F_i)$ is calculated by Equation S1,

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$$F_i = A_i / \text{SUM}(A_1, A_2, A_3...A_i)$$
 (S1)

(3) The Si/O and Si/C ratio of $C_xH_yO_zSi_n$ ions at each equivalent day are calculated by Equation

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$$m_{\rm Si} = {\rm SUM}(F_{\rm i} \times n_{\rm i} \times M_{\rm Si} / M_{\rm C_{\rm xi}H_{\rm vi}O_{\rm zi}Si_{\rm ni}})$$
(S2)

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$$m_{\rm O} = \text{SUM}(F_{\rm i} \times z_{\rm i} \times M_{\rm O} / M_{\rm C_{\rm xi}H_{\rm vi}O_{\rm zi}Si_{\rm ni}})$$
(S3)

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$$m_{\rm C} = {\rm SUM}(F_{\rm i} \times {\rm x}_{\rm i} \times {\rm M}_{\rm C} / {\rm M}_{{\rm C}_{\rm xi} {\rm H}_{\rm vi} {\rm O}_{\rm zi} {\rm Si}_{\rm ni}})$$
(S4)

$$n/z = \frac{\frac{m_{Si}}{M_{Si}}}{\frac{m_{O}}{M_{O}}}$$
(S5)

$$n/x = \frac{\frac{m_{\rm Si}}{M_{\rm Si}}}{\frac{m_{\rm C}}{M_{\rm C}}}$$
(S6)

where M is the molar mass of one specific element (Si, O, C and H) or $C_xH_yO_zSi_n$ ions; *m* is the total mass of Si, O or C in all $C_xH_yO_zSi_n$ ions. The related descriptions have been given in Text S1 in the revised *Supplement*.

For the calculation results, there may be some uncertainties due to the assignments of peaks in the HR-ToF-AMS and the fragmentation processes of the AMS ionization. The revised Si/O and Si/C mass ratios have been updated in Figure S8 and S11. The related descriptions have been revised in Lines 287-288 in the revised manuscript.

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100 Technical: Line numbers refer to track changes version.

- 101 Line 305: I believe this should be Si-C, not S-C.
- 102 **Re**: The S-C has been modified into Si-C in Line 299 in the revised manuscript.
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Line 256-257: This statement is incorrect. The Alton and Browne papers say the opposite – the products measured there are predicted to have high vapor pressures that wouldn't partition to aerosol under most ambient conditions (assuming absorptive partitioning). Wu and Johnston also show that a significant fraction of the products have a logC* >2 making them also volatile. **Re**: The original statement "In fact, most D5 oxidation products have been shown to be nearly non-volatile" has been deleted in the revised manuscript.

111 Line 433-435: The Pennington et al results were for aerosol from multiple different siloxanes,

112 not just D5. I also find the statement somewhat misleading. While the numbers reported here

- 113 do encompass the Pennington et al number, the lower end numbers here that are comparable to
- the Pennington et al numbers are for locations with a much lower population than Los Angeles.
- 115 This difference is important given that VMS to some extent at least scales with population.
- 116 **Re**: The results of Pennington et al. (*Atmos. Chem. Phys.*, 2021, 21, 18247-18261) have been
- 117 compared with total cVMS SOA at urban sites, as shown in Lines 396-399 in the revised118 manuscript.
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120 **References**

- 121 Aiken, A. C., DeCarlo, P. F., and Jimenez, J. L.: Elemental Analysis of Organic Species with
- 122 Electron Ionization High-Resolution Mass Spectrometry, Anal. Chem., 79, 8350-8358,
- 123 https://doi.org/10.1021/ac071150w, 2007.
- Re: We thank the reviewer for providing this literature. It has been cited properly in the revised *Supplement*.
- 126
- 127 Sincerely yours,
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- 129 Chong Han, Professor
- 130 School of Metallurgy, Northeastern University
- 131 Shenyang 110819, China
- 132 E-mail: <u>hanch@smm.neu.edu.cn</u>
- 133
- 134 Shao-Meng Li, Chair Professor
- 135 College of Environmental Sciences and Engineering, Peking University
- 136 Beijing, China 100871
- 137 E-mail: shaomeng.li@pku.edu.cn